

International Standard

ISO 18563-3

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Non-destructive testing— Characterization and verification of ultrasonic phased array equipment—

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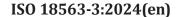
Complete systems

Essais non destructifs - Caractérisation et vérification de L'appareillage ultrasonore multiélément —

Partie 3: Systèmes complets

Our Partie 3: Systèmes complets

Our Partie 3: Systèmes complets





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Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular, the different approval criteria needed for the different types of ISO document should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2 (see www.iso.org/directives).

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For an explanation of the voluntary nature of standards, the meaning of ISO specific terms and expressions related to conformity assessment, as well as information about ISO's adherence to the World Trade Organization (WTO) principles in the Technical Barriers to Trade (TBT), see www.iso.org/iso/foreword.html.

This document was prepared by Technical Committee ISO/TC 135 *Non-destructive testing*, Subcommittee SC 3 *Ultrasonic testing*, in collaboration with the European Committee for Standardization (CEN) Technical Committee CEN/TC 138, *Non-destructive testing*, in accordance with the Agreement on technical cooperation between ISO and CEN (Vienna Agreement).

This second edition cancels and replaces the first edition (ISO 18563-3:2015), which has been technically revised.

The main changes are as follows:

- integration of matrix array probes;
- deletion of group 1 and 2 tests;
- addition of a clause on the use of imaging for complete system verification (9.4.3) as a simplification for a more functional standard (characterisation of beams moved to Annex A);
- addition of signal processing techniques using arrays (e.g. total focusing technique (TFM)) in the scope.

A list of all parts in the ISO 18563 series can be found on the ISO website.

Any feedback or questions on this document should be directed to the user's national standards body. A complete listing of these bodies can be found at www.iso.org/members.html.

Non-destructive testing — Characterization and verification of ultrasonic phased array equipment —

Part 3:

Complete systems

1 Scope

This document addresses ultrasonic test systems implementing array probes, for contact technique (with or without wedge) or for immersion technique, with centre frequencies in the range of 0,5 MHz to 10 MHz.

This document provides methods and acceptance criteria for determining the compliance of the complete system (see 3.2). Its purpose is for the verification of the correct operation of the system prior to testing or verification of the absence of degradation of the system.

The methods are not intended to prove the suitability of the system for particular applications but are intended to prove the capability of the complete system (used for an application) to operate correctly according to the settings used. Tests can be performed on individual ultrasonic beams (for phased array technique, see 9.4.4) or on resulting images (for phased array technique and total focusing technique, see 9.4.3).

The tests can be limited to the functions that are intended to be used for a certain application.

This document does not cover the sensitivity setting of the system for a specific application. Nor does it apply to the characterization or verification of the mechanical scanning equipment. It is intended that these items will be covered by the test procedure.

This document does not address the phased array technique using tandem technique.

The characterization of beams, as recommended in case of dead elements or for more in-depth knowledge of the beams, is presented in <u>Annex A</u>. It is not applicable for signal processing technology using arrays.

NOTE Unless stated otherwise, in this document 'TFM' and 'TFM technique' refer to the total focusing technique as defined in ISO 23243, and to related techniques, see for example ISO 23865 and ISO 23234.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO 5577, Non-destructive testing — Ultrasonic testing — Vocabulary

ISO 9712, Non-destructive testing — Qualification and certification of NDT personnel

ISO 18563-1, Non-destructive testing — Characterization and verification of ultrasonic phased array equipment — Part 1: Instruments

ISO 18563-2, Non-destructive testing — Characterization and verification of ultrasonic phased array equipment — Part 2: Probes

ISO 22232-2, Non-destructive testing — Characterization and verification of ultrasonic test equipment — Part 2: Probes

ISO 23243, Non-destructive testing — Ultrasonic testing with arrays — Vocabulary

3 Terms and definitions

For the purposes of this document, the terms and definitions given in ISO 5577, ISO 23243 and the following apply.

ISO and IEC maintain terminology databases for use in standardization at the following addresses:

- ISO Online browsing platform: available at https://www.iso.org/obp
- IEC Electropedia: available at https://www.electropedia.org/

3.1

combined equipment

connected set including the instrument, the array probe (with wedge if applicable) and connecting cables, including adapters

[SOURCE: ISO 23243:2020. Modified – array and wedge added]

3.2

complete system

combined equipment including the settings for a given mode of operation

Note 1 to entry: Settings are specific values or ranges of values, e.g. electronic scanning or steering range.

3.3

reference system

complete system, including an instrument according to ISO 18563-1 and an array probe initially according to ISO 18563-2, on which all of the applicable tests defined in $\underline{\text{Clause 9}}$ of this document have been performed successfully

3.4

identical system

complete system in which instrument, array probe, wedge, connecting cables and the settings for a given mode of operation are identical to those of the reference system

Note 1 to entry: Components are identical if from the same manufacturer and the same model.

3.5

system record sheet

document for reporting the results for a complete system which enables a comparison with the values obtained from the reference system

4 Symbols

For the purposes of this document, the symbols given in Table 1 apply.

Table 1 — Symbols

Symbol	Unit	Definitions
$(X_C; Z_C)$	mm; mm	Coordinates of the position of the centre of the reference reflector
$(X_M; Z_M)$	mm; mm	Coordinates of the position of maximum amplitude of an indication
A_{el}	V or % FSH	Amplitude of one elementary signal
	mm	Contact technique: reduced projected sound path length
$a_{\rm i}$		Immersion technique: distance between the orthogonal projection of the axis of the sidedrilled hole on the test surface and the centre of the probe front surface
A_{\max}	V or % FSH	Maximum value of the amplitudes of all elementary signals
A_{\min}	V or % FSH	Minimum value of the amplitudes of all elementary signals, excluding the dead elements
$A_{\rm ref}$	V or % FSH	Median value of the amplitudes of all elementary signals

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Table 1 (continued)

Symbol	Unit	Definitions
D	mm	Diagonal of the active aperture
D_{CM}	mm	Distance between the centre of a side-drilled hole and the point of maximum amplitude of the indication of this hole
G_{ref}	dB	Reference gain
N	mm	Near-field length associated with the active aperture
р	mm	Pitch
X_{s}	mm	Distance between the probe front surface and the probe index point for the studied beam
ΔS_{el}	dB	Relative sensitivity of an element
Θ	0	Angle of refraction
λ	mm	Wavelength

5 General requirements for conformity

5.1 General

All following tests shall be performed with an instrument that complies with ISO 18563-1 and an array that initially complied with ISO 18563-2.

The tests can be limited to the functions that are intended to be used for a certain application, e.g. used channels of the instrument or used part of the array or specific settings for a specified mode of operation.

When all required tests have been successfully conducted, the complete system is considered to conform to this document.

5.2 Reference system

- a) The tests to be performed prior to the first use of a complete system are described in $\underline{\text{Table 4}}$.
 - When all required tests have been successfully conducted, this complete system may be used as a reference system. The results of the measurements made are the base values.
- b) A system record sheet of these base values shall be created.

5.3 Identical system

- a) When an identical system is created, and/or when using other channels of the instrument and duplicating the settings, or after a maintenance operation or after the replacement of a system component, the tests as described in <u>Table 4</u> shall be performed again.
- b) The results of the measurements made on the identical system shall be recorded in the system record sheet and compared against the base values.

5.4 Periodic checks

- a) For a periodic check of correct operation of the system, the tests as described in <u>Table 4</u> shall be performed again.
- b) The frequency of checking of the complete system shall be specified in the test procedure, e. g. before starting and at the end of the non-destructive testing or daily, weekly, monthly, depending on the application.
- c) Each periodic check shall be documented on the system record sheet, either by recording the values of the checks or by stating that the results are within the acceptance criteria.